

1:10 Clock Fanout Buffer with Output Enable

Features

- Low-voltage operation
- V_{DD} range from 2.5 to 3.3V
- 1:10 fanout
- Drives either a 50-ohm or 75-ohm transmission line
- · Over voltage tolerant input hot swappable
- Low input capacitance
- · Low output skew
- · Low propagation delay
- Typical (tpd < 4 ns)
- High-speed operation > 200 MHz
- LVTTL-/LVCMOS-compatible input
- Output disable to three-state
- · Industrial versions available
- Packages available include: SOIC/SSOP

Block Diagram

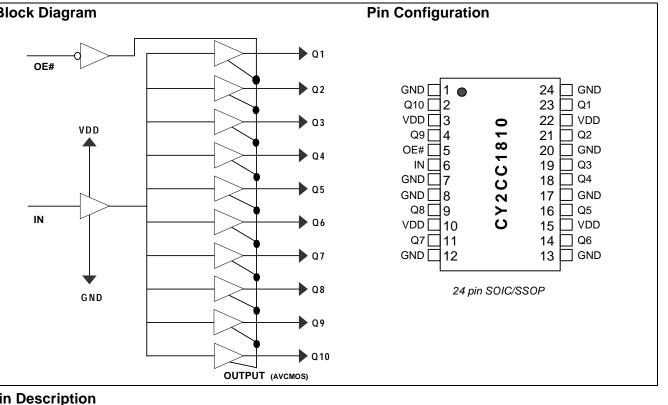
Description

The Cypress series of network circuits is produced using advanced 0.35-micron CMOS technology, achieving the industries fastest logic and buffers.

The Cypress CY2CC1810 fanout buffer features one input and ten three-state outputs.

Designed for data communications clock management applications, the large fanout from a single input reduces loading on the input clock.

AVCMOS-type outputs dynamically adjust for variable impedance-matching and eliminate the need for seriesdamping resistors; they also reduce noise overall.



Pin Description

Pin Number	Pin Name	Pin I	Description
1,7,8,12,13,17,20,24	G _{ND}	Ground	Power
3,10,15,22	V _{DD}	Power Supply	Power
5	OE#	Output Enable	LVTTL/LVCMOS
6	IN	Input	LVTTL/LVCMOS
2,4,9,11,14,16,18,19,21,23	Q10Q1	Output	AVCMOS

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Maximum Ratings^{[1][2]}

Storage Temperature:	–65°C to + 150°C
Ambient Temperature:	40°C to +85°C
Supply Voltage to Ground Potential	
V _{CC}	–0.5V to 4.6V
Input	–0.5V to 5.8V

Supply Voltage to Ground Potential	
(Outputs only)0.5V	to V_{DD} + 0.5V
DC Output Voltage0.5V	' to V _{DD} + 0.5V
Power Dissipation	0.75W

DC Parameter @ 3.3V V_{DD} = 3.3V \pm 5%, T_A= -40°C to +85°C (see Figure 6)

Parameter	Description	Conditions		Min.	Тур.	Max.	Unit
V _{OH}	Output High Voltage	$V_{DD} = Min., V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -12 \text{ mA}$	2.3	3.3		V
V _{OL}	Output Low Voltage	$V_{DD} = Min., V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 12 mA		0.2	0.5	V
V _{IH}	Input High Voltage	Guaranteed Logic High Level		2		5.8	V
V _{IL}	Input Low Voltage	Guaranteed Logic Low Level				0.8	V
I _{IH}	Input High Current	V _{DD} = Max.	V _{IN} = 2.7V			1	uA
IIL	Input Low Current	$V_{DD} = Max.$	$V_{IN} = 0.5V$			-1	uA
l _l	Input High Current	$V_{DD} = Max., V_{IN} = V_{DD}(Max)$				20	uA
V _{IK}	Clamp Diode Voltage	$V_{DD} = Min., I_{IN} = -18 \text{ mA}$			-0.7	-1.2	V
I _{OK}	Continuous Clamp Current	V _{DD} = Max., V _{OUT} = GND				-50	mA
O _{OFF}	Power-down Disable	$V_{DD} = GND, V_{OUT} = < 4.5V$				100	uA
V _H	Input Hysteresis				80		mV

DC Parameter @ 2.5V V_{DD} = 2.5V ± 5%, T_A = -40°C to +85°C (see Figure 1)

Parameter	Description	Conditions		Min.	Тур.	Max.	Unit
Val	Output High Voltage	V _{DD} = Min., V _{IN} = V _{IH} or V _{II}	I _{OH} = -7 mA	1.8			V
V _{OH}		$v_{DD} = 10111.$, $v_{IN} = v_{IH} OI v_{IL}$	I _{OH} = 12 mA	1.6			V
V _{OL}	Output Low Voltage	$V_{DD} = Min., V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 12 mA			0.65	V
V _{IH}	Input High Voltage	Guaranteed Logic High Level		1.6		5.0	V
V _{IL}	Input Low Voltage	Guaranteed Logic Low Level				0.8	V
I _{IH}	Input High Current	V _{DD} = Max.	V _{IN} = 2.4V			1	uA
IIL	Input Low Current	V _{DD} = Max.	V _{IN} = 0.5V			-1	uA
l	Input High Current	$V_{DD} = Max., V_{IN} = V_{DD}(Max.)$				20	uA
V _{IK}	Clamp Diode Voltage	$V_{DD} = Min., I_{IN} = -18 \text{ mA}$			-0.7	-1.2	V
I _{OK}	Continuous Clamp Current	V _{DD} = Max., V _{OUT} = GND				-50	mA
O _{OFF}	Power-down Disable	$V_{DD} = GND, V_{OUT} = < 4.5V$				100	uA
V _H	Input Hysteresis				80		mV

Capacitance

Symbol	Description	Test Conditions	Тур.	Max.	Unit
C _{IN}	Input Capacitance	$V_{IN} = 0V$	2.5		pF
C _{OUT}	Output Capacitance	V _{OUT} = 0V	6.5		pF

Note:

Stresses greater than those listed under absolute maximum ratings may cause permanent damage to the device. This is intended to be a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
Multiple Supplies: The voltage on any input or I/O pin cannot exceed the power pin during power-up. Power supply sequencing is NOT required.



Power Supply Characteristics (See Figure 1)

Parameter	Description	Test Conditions		Min.	Тур.	Max.	Unit
Δ_{ICC}	Delta I _{CC} Quiescent Power Supply Current	$(I_{DD} @ V_{DD} = Max. and V_{IN} = V_{DD}) - Max. and V_{IN} = V_{DD} - 0.6V)$	- (I _{DD} @ V _{DD} =			50	uA
ICCD	Dynamic Power Supply Current	V _{DD} = Max. Input toggling 50% Duty Cycle, Outputs Open	fL= fMAX OE# = V _{DD}			0.63	mA/ MHz
Ι _C	Total Power Supply Current	V _{DD} = Max. Input toggling 50% Duty Cycle, Outputs Open fL = 40 MHz	fL=100 MHz OE# = GND			25	mA

High-frequency Parametrics

Parameter	Description	Test Conditions		Min.	Тур	Max	Unit
DJ	Jitter, Deterministic	50% duty cycle tW(50–50) The "point to point load circuit" Output Jitter – Input Jitter	See Figure 8			20	ps
F _{max}	Maximum frequency50% duty cycle tW(50–50)See Figure 6 $V_{DD} = 3.3V$ Standard Load Circuit.		160	MHz			
		50% duty cycle tW(50–50) The "point to point load circuit"	See Figure 8			200	
F _{max(20)}	Maximum frequency V _{DD} = 3.3 V	20% duty cycle tW(20–80) The "point to point load circuit" $V_{IN} = 3.0V/0.0V V_{OUT} = 2.3V/0.4V$	See Figure 8			200	MHz
	Maximum frequency $V_{DD} = 2.5 V$	The "point to point load circuit" $V_{IN} = 2.4V/0.0V V_{OUT} = 1.7V/0.7V$	See Figure 3			100	
t _W	Minimum pulse $V_{DD} = 3.3 V$	The "point to point load circuit" $V_{IN} = 3.0V/0.0V F = 100 MHz$ $V_{OUT} = 2.0V/0.8V$	See Figure 7	2			ns
	Minimum pulse V _{DD} = 2.5 V	The "point to point load circuit" $V_{IN} = 2.4V/0.0V F = 100 MHz$ $V_{OUT} = 1.7V/0.7V$	See Figure 2	1			

AC Switching Characteristics @ 3.3V V_{DD} = 3.3V ± 5%, T_A = -40°C to +85°C (See Figure 6)

Parameter	Description		Min.	Тур.	Max.	Unit
t _{PLH}	Propagation Delay – Low to High	See Figure 9	1.5	3	3.9	nS
t _{PHL}	Propagation Delay – High to Low		1.5	3	3.9	nS
t _{PHZ}	Propagation Delay – High to High Z	See Figure 10		4		nS
t _{PLZ}	Propagation Delay – Low to High Z			3		nS
t _R	Output Rise Time	See Figure 9		0.8		V/nS
t _F	Output Fall Time			0.8		V/nS
t _{SK(0)}	Output Skew: Skew between outputs of the same package (in phase)	See Figure 12			0.2	nS
t _{SK(p)}	Pulse Skew: Skew between opposite transitions of the same output $(t_{PHL} - t_{PLH})$	See Figure 11			0.2	nS
t _{SK(t)}	Package Skew: Skew between outputs of different packages at the same power supply voltage, temperature and package type.	See Figure 13			0.3	nS
t _{OFF}	Delay from OE to Driver Off				4.0	nS
t _{ON}	Delay from OE to Driver on				4.0	nS



AC Switching Characteristics @ 2.5V $V_{DD} = 2.5V \pm 5\%$, $T_A = -40^{\circ}C$ to +85°C (See Figure 1)

Parameter	Description		Min.	Тур.	Max.	Unit
t _{PLH}	Propagation Delay – Low to High	See Figure 4	1.5	3.8	3.5	nS
t _{PHL}	Propagation Delay – High to Low		1.5	3.8	3.5	nS
t _{PHZ}	Propagation Delay – High to High Z	See Figure 5		5		nS
t _{PLZ}	Propagation Delay – Low to High Z			4		nS
t _R	Output Rise Time	See Figure 4		0.4		V/nS
t _F	Output Fall Time			0.6		V/nS
t _{SK(0)}	Output Skew: Skew between outputs of the same package (in phase)	See Figure 12			0.2	nS
t _{SK(p)}	Pulse Skew: Skew between opposite transitions of the same output $(t_{PHL} - t_{PLH})$	See Figure 11			0.2	nS
t _{SK(t)}	Package Skew: Skew between outputs of different packages at the same power supply voltage, temperature and package type.	See Figure 13			0.3	nS
t _{OFF}	Delay from OE to Driver Off				5.0	nS
t _{ON}	Delay from OE to Driver on				5.0	nS

Parameter Measurement Information: V_{DD} @ 2.5V^[3,5,6]

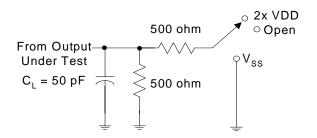


Figure 1. Load Circuit

Figure 2. Voltage Waveforms–Pulse Duration

1.25 V

-- 1.25 V

500 ohm

w(20-80)

t_{w(50-50)}

1.25 V

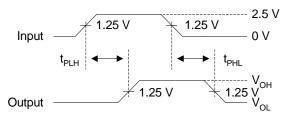


Figure 4. Voltage Waveforms–Propagation Delay Times^[9]

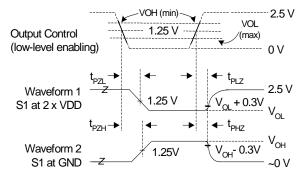


Figure 5. Voltage Waveforms-Enable and Disable Times^[4,7,8]

Table 1.

Test	S1	
t _{PLH} /t _{PHL}	Open	See Figure 4
t _{PLZ} /t _{PZL}	$2 \times V_{DD}$	See Figure 5
t _{PHZ} /t _{PZH}	V _{SS}	See Figure 5

Notes:

Input

Input

 $\ensuremath{\mathsf{C}}\xspace_{\ensuremath{\mathsf{L}}}$ includes probe and jig capacitance. 3

From Output-

Under Test

 $C_L = 3 pF$

- Waveform 1 is for an output with internal conditions such that the output is LOW, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is HIGH except when disabled by the output control. All input pulses are supplied by generators having the following characteristics: PRR < 10 MHz, Zo = 50Ω , t_R < 2.5 nS, t_F < 2.5 nS. 4.
- 5.
- 6. 7. Outputs are measured one at a time with one transition per measurement.

Figure 3. Point-to-Point Load Circuit

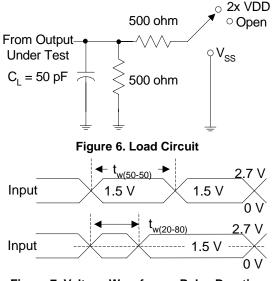
- t_{PLZ} and t_{PHZ} are the same as $t_{\mathsf{DIS}}.$
- t_{PZL} and t_{PZH} are the same as t_{EN} . t_{PLH} and t_{PHL} are the same as t_{PD} . 8.
- 9.

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Parameter Measurement Information: V_{DD} @ 3.3V^[10,12,13]





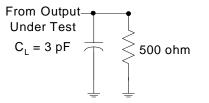


Figure 8. Point-to-Point Load Circuit

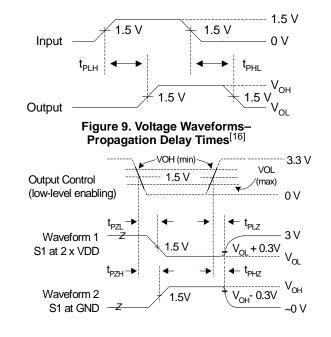


Figure 10. Voltage Waveforms– Enable and Disable Times^[11,14,15]

Test	S1	
t _{PLH} /t _{PHL}	Open	See Figure 9
t _{PLZ} /t _{PZL}	2xVDD	See Figure 10
t _{PHZ} /t _{PZH}	VSS	Gee rigule to

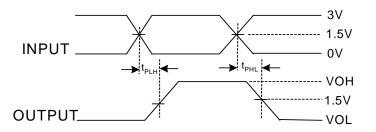


Table 2.

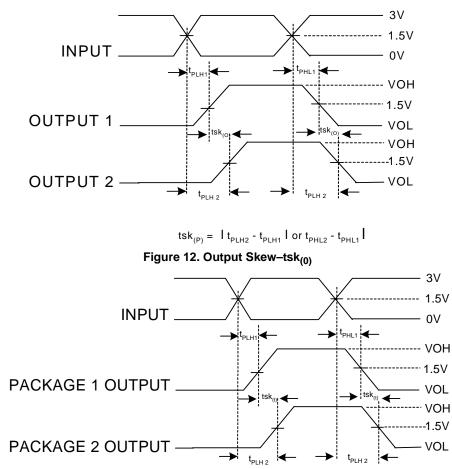


Figure 11. Pulse Skew-tsk(p)

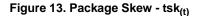
Notes:

- 10. CL includes probe and jig capacitance
- Waveform 1 is for an output with internal conditions such that the output is LOW, except when disabled by the output control. Waveform 2 is for an output with 11.
- internal conditions such that the output is HIGH, except when disabled by the output control. All input pulses are supplied by generators having the following characteristics: PRR < 10 MHz, Zo = 50Ω , t_R < 2.5 nS, t_F < 2.5 nS. 12.
- The outputs are measured one at a time with one transition per measurement. 13.
- 14. t_{PLZ} and t_{PHZ} are the same as $t_{\mathsf{DIS}}.$
- 15.
- t_{PZL} and t_{PZH} are the same as t_{EN} . tPLH and tPHL are the same as t_{PD} . 16.





 $tsk_{(t)} = It_{PLH2} - t_{PLH1} I \text{ or } t_{PHL2} - t_{PHL1} I$

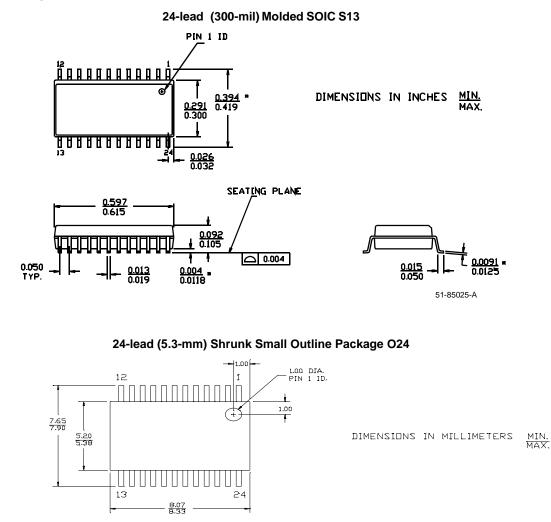


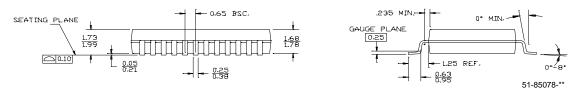
Ordering Information

Part Number	Package Type	Product Flow	
CY2CC1810SI	24-pin SOIC	Industrial, –40° to 85°C	
CY2CC1810SIT	24-pin SOIC–Tape and Reel	Industrial, –40° to 85°C	
CY2CC1810OI	24-pin SSOP	Industrial, –40° to 85°C	
CY2CC1810OIT	24-pin SSOP–Tape and Reel	Industrial, –40° to 85°C	
CY2CC1810SC	24-pin SOIC	Commercial, 0°C to 70°C	
CY2CC1810SCT	24-pin SOIC–Tape and Reel	Commercial, 0°C to 70°C	
CY2CC1810OC	24-pin SSOP	Commercial, 0°C to 70°C	
CY2CC1810OCT	24-pin SSOP–Tape and Reel	Commercial, 0°C to 70°C	



Package Drawing and Dimensions





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Document History Page

Document Title: CY2CC1810 1:10 Clock Fanout Buffer with Output Enable Document #: 38-07055					
REV.	ECN NO.	Issue Date	Orig. of Change	Description of Change	
**	107080	06/07/01	IKA	Convert from IMI to Cypress format	
*A	114316	05/08/02	TSM	ΔI_{DD} validation	
*В	119147	10/07/02	RGL	Added 5.8 as the Max. value for VIH in the DC Parameters @3.3V table. Changed the Max. value of the VIH from 5.8 to 5.0 in the DC Parameters @2.5V table.	
*C	122742	12/14/02	RBI	Added power up requirements to maximum ratings information.	